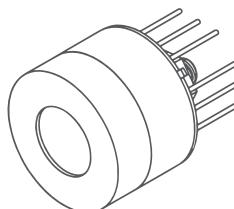
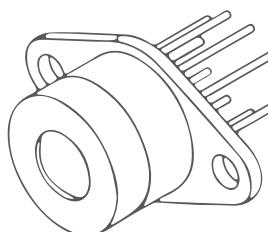


PVM-8 SERIES

HgCdTe thermoelectrically cooled photovoltaic multi-junction infrared detectors



2TE-T08



2TE-T066

FEATURES

- Spectral range: 2.0 to 10.0 μm
- Large active areas
- Back-side illuminated
- No minimum order quantity required

APPLICATIONS

- Gas detection, monitoring and analysis:
 CH_4 , H_2S , NO_2 , SO_x
- FTIR spectroscopy

SERIES DESCRIPTION

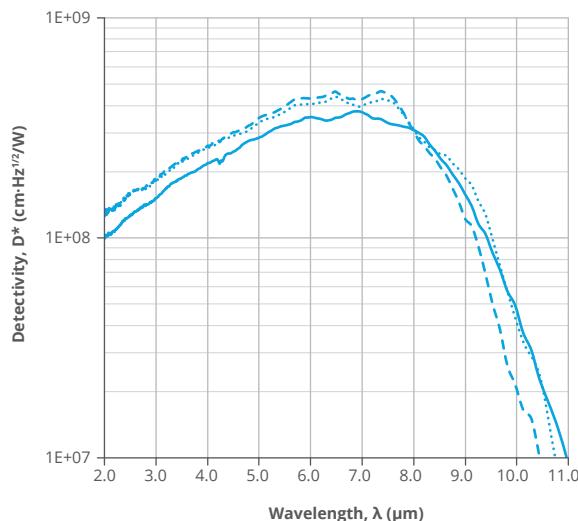
Detector symbol	Cooling (p. 191)	Temperature sensor (p. 192)	Active area, A, mm \times mm	Optical immersion	Package	Acceptance angle, Φ , deg.	Window (p. 193)
PVM-2TE-8-1 \times 1-T08-wZnSeAR-70			1 \times 1		TO8		
PVM-2TE-8-1 \times 1-T066-wZnSeAR-70					TO66		
PVM-2TE-8-2 \times 2-T08-wZnSeAR-70	2TE $T_{\text{chip}} \approx 230\text{K}$	thermistor	2 \times 2	no	TO8	~70	wZnSeAR (3 deg. zinc selenide, anti-reflection coating)
PVM-2TE-8-2 \times 2-T066-wZnSeAR-70					TO66		
PVM-2TE-8-3 \times 3-T08-wZnSeAR-70			3 \times 3		TO8		
PVM-2TE-8-3 \times 3-T066-wZnSeAR-70					TO66		

SPECIFICATION ($T_{\text{amb}} = 293\text{ K}$, $V_b = 0\text{ V}$)

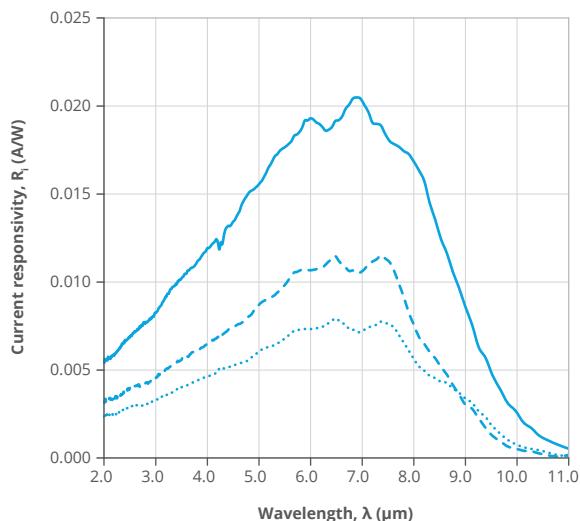
Detector symbol	Cut-on wavelength (10%)	Peak wavelength	Specific wavelength	Cut-off wavelength (10%)	Detectivity		Current responsivity		Time constant	Dynamic resistance
	$\lambda_{\text{cut-on}}$	λ_{peak}	λ_{spec}	$\lambda_{\text{cut-off}}$	$D^*(\lambda_{\text{peak}}/20\text{kHz})$	$D^*(\lambda_{\text{spec}}/20\text{kHz})$	$R_i(\lambda_{\text{peak}})$	$R_i(\lambda_{\text{spec}})$	τ	R_d
	μm	μm	μm	μm	$\text{cm}\cdot\text{Hz}^{1/2}/\text{W}$	$\text{cm}\cdot\text{Hz}^{1/2}/\text{W}$	A/W	A/W	ns	Ω
PVM-2TE-8-1 \times 1-T08-wZnSeAR-70							0.02	0.015	0.017	
PVM-2TE-8-1 \times 1-T066-wZnSeAR-70										
PVM-2TE-8-2 \times 2-T08-wZnSeAR-70	2.0	7.0 \pm 1.0	8.0	10.0	4.0×10^8	3.0×10^8	0.01	0.0075	0.008	4
PVM-2TE-8-2 \times 2-T066-wZnSeAR-70										120
PVM-2TE-8-3 \times 3-T08-wZnSeAR-70							0.007	0.005	0.006	400
PVM-2TE-8-3 \times 3-T066-wZnSeAR-70										

SPECTRAL RESPONSE (Typ., $T_{\text{amb}} = 293 \text{ K}$)

— PVM-2TE-8-1x1-T08/TO66-wZnSeAR-70
 - - PVM-2TE-8-2x2-T08/TO66-wZnSeAR-70
 ... PVM-2TE-8-3x3-T08/TO66-wZnSeAR-70



— PVM-2TE-8-1x1-T08/TO66-wZnSeAR-70
 - - PVM-2TE-8-2x2-T08/TO66-wZnSeAR-70
 ... PVM-2TE-8-3x3-T08/TO66-wZnSeAR-70



MECHANICAL LAYOUT AND PINOUT

- 2TE-T08 package
 - Technical drawing (p. 203)
- 2TE-TO66 package
 - Technical drawing (p. 205)

RECOMMENDED AMPLIFIERS

Detector symbol	Amplifier type
PVM-2TE-8-1x1-T08-wZnSeAR-70	AIP series (p. 126)
PVM-2TE-8-2x2-T08-wZnSeAR-70	PIP series (p. 129)
PVM-2TE-8-3x3-T08-wZnSeAR-70	MIP series (p. 132)
	SIP-T08 series (p. 135)

ABSOLUTE MAXIMUM RATINGS

Parameter	Test conditions/remarks	Value	Unit
Ambient operating temperature, T_{amb}	Operation at $T_{\text{amb}} > 30^\circ\text{C}$ may increase the active element temperature and reduce the performance of the detector below specified parameters	-20 to 30	$^\circ\text{C}$
Storage temperature, T_{stg}		-20 to 50	$^\circ\text{C}$
Soldering temperature	Within 5 s or less	≤ 300	$^\circ\text{C}$
Storage humidity	No dew condensation	10 to 90	%
Maximum incident optical power density	Continuous wave (CW) or single pulses $> 1 \mu\text{s}$ duration	100	W/cm^2
	Single pulses $< 1 \mu\text{s}$ duration	1	MW/cm^2
Maximum bias voltage, $V_{\text{b max}}$	No bias voltage needed	-	-
Maximum TEC voltage, $V_{\text{TEC max}}$	2TE	1.3	V
Maximum TEC current, $I_{\text{TEC max}}$	2TE	1.2	A

Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. Constant or repeated exposure to absolute maximum rating conditions may affect the quality and reliability of the device.